## PATENT APPLICATION



## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Akio KITAMURA et al.

Group Art Unit: 3726

Application No.: 10/750,871

Examiner: E. OMGBA

Filed: January 5, 2004

Docket No : 118217

For: PRESS-IN APPARATUS FOR Z PROFILE SHEET PILE AND PRESS-IN METHOD OF Z

PROFILE SHEET PILE

## INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Pursuant to 37 CFR §1.56, the attention of the Patent and Trademark Office is hereby directed to the reference(s) listed on the attached PTO-1449. Unless otherwise indicated herein, one copy of each reference is attached. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the reference(s) be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

- This Information Disclosure Statement is being filed more than three months after the U.S. filing date and after the mailing date of a Final Rejection, Notice of Allowance, or other action that closes prosecution (e.g., Quayle Action), but before payment of the Issue Fee. Attached is our Check No. 193167 in the amount of \$180.00 in payment of the fee under 37 CFR §1.17(p). Please credit or debit Deposit Account No. 15-0461 as needed to ensure consideration of the disclosed information.
  - a. I hereby certify that each item of information contained in this
    Information Disclosure Statement was first cited in any communication from a
    foreign patent office in a counterpart foreign application not more than three
    months prior to the filing of this Information Disclosure Statement.
     37 CFR §1.97(e)(1).
- 2. One or more reference cited herein was cited in a counterpart foreign application. An English language version of the foreign Office Action is attached for the Examiner's information. See Reference(s) 1-3.
- 3. An English language Abstract of one or more non-English language reference is attached. See Reference(s) 1 and 2.

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4. A computer-generated English language translation of one or more Japanese Patent Publication cited herein has been obtained from the website of the Japanese Patent Office ([http://www.jpo.go.jp]), and is attached, but has not been reviewed for accuracy. See Reference(s) 1 and 3.

Respectfully submitted,

William P. Berridge Registration No. 30,024

Timothy S. Smith Registration No. 58,355

WPB:TSS/tbm

Date: May 30, 2007

OLIFF & BERRIDGE, PLC P.O. Box 19928 Alexandria, Virginia 22320 Telephone: (703) 836-6400 DEPOSIT ACCOUNT USE AUTHORIZATION Please grant any extension necessary for entry; Charge any fee due to our Deposit Account No. 15-0461

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